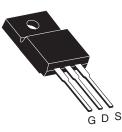
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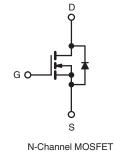


Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.050		
Q _g (Max.) (nC)	46			
Q _{gs} (nC)	11			
Q _{gd} (nC)	22			
Configuration	Single			

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- Available RoHS*
- 175 °C Operating Temperature
 Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. The isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIZ34GPbF
	SiHFIZ34G-E3
SnPb	IRFIZ34G
	SiHFIZ34G

ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	60	V		
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	20		
		$T_C = 100 ^{\circ}C$		14	A	
Pulsed Drain Current ^a			I _{DM}	80		
Linear Derating Factor			0.28	W/°C		
Single Pulse Avalanche Energy ^b		E _{AS}	300	mJ		
Maximum Power Dissipation	T _C = 25 °C		P _D 42		W	
Peak Diode Recovery dV/dt ^c				5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	1	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
			-	1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. V_{DD} = 25 V, starting T_J = 25 °C, L = 875 μ H, R_G = 25 Ω , I_{AS} = 20 A (see fig. 12).

c. $I_{SD} \leq 30$ A, dI/dt ≤ 200 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq 175$ °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	ТҮР		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65							
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6				°C/W			
SPECIFICATIONS $T_J = 25 \degree C$,	unless otherv	vise noted							
PARAMETER	SYMBOL			ONS	MIN.	TYP.	MAX.	UNI	
Static									
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 2	50 μA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.065	-	V/°	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$			2.0	-	4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
		V _{DS} =	= 60 V, V _{GS}	= 0 V	-	-	25	<u> </u>	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 48 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 \text{ °C}$			-	-	250	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D	= 12 A ^b	-	-	0.050	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D =	12 A ^b	9.2	-	-	S	
Dynamic									
Input Capacitance	C _{iss}		$V_{aa} = 0.V$		-	1200	-		
Output Capacitance	C _{oss}	$V_{GS} = 0 V,$ $V_{DS} = 25 V,$ f = 1.0 MHz, see fig. 5 f = 1.0 MHz		-	600	-	pF		
Reverse Transfer Capacitance	C _{rss}			-	100	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg				-	-	46	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		$I_D = 30 \text{ A}, V_{DS} = 48 \text{ V}$ see fig. 6 and 13 ^b	-	-	11		
Gate-Drain Charge	Q _{gd}	see ng	e lig. 6 and 15°	-	-	22			
Turn-On Delay Time	t _{d(on)}				-	13	-		
Rise Time	t _r	$V_{DD} = 30 \text{ V}, \text{ I}_{D} = 30 \text{ A}$		-	100	-	1		
Turn-Off Delay Time	t _{d(off)}		12 Ω , R _D = see fig. 10 ^t		-	29	-	ns	
Fall Time	t _f		0		-	52	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	L _S			-	7.5	-			
Drain-Source Body Diode Characteristic	s	I			<u> </u>	<u> </u>	1		
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	- A		
Pulsed Diode Forward Currenta	I _{SM}			-	-	80			
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, I_S = 20 \ A, V_{GS} = 0 \ V^b$		-	-	1.6	V		
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = 30 \text{ A}, dI/dt = 100 \text{ A}/\mu\text{s}^b$		-	120	230	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.70	1.4	μΟ		
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time i	s negligible (turn	on is dor	ninated by	leandl	Ln)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 μ s; duty cycle \leq 2 %



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

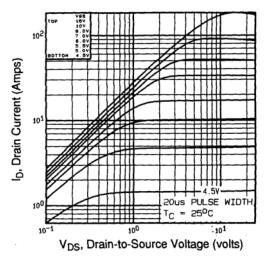


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

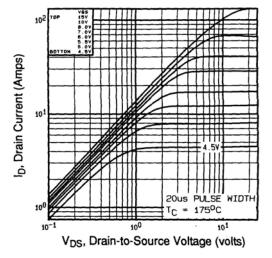
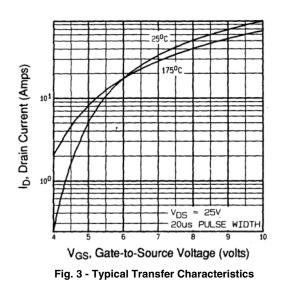


Fig. 2 - Typical Output Characteristics, T_C = 175 $^\circ C$



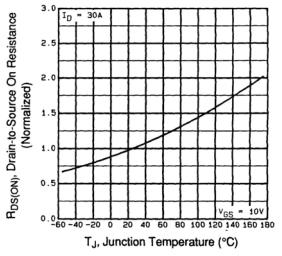


Fig. 4 - Normalized On-Resistance vs. Temperature

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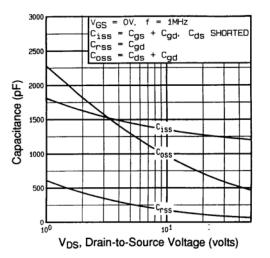


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

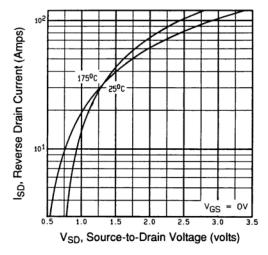


Fig. 7 - Typical Source-Drain Diode Forward Voltage

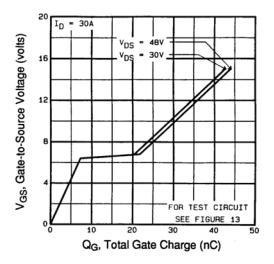


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

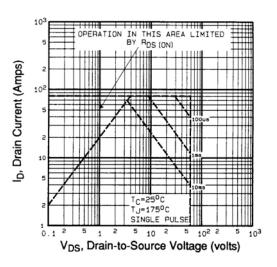


Fig. 8 - Maximum Safe Operating Area



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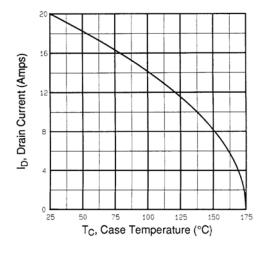


Fig. 9 - Maximum Drain Current vs. Case Temperature

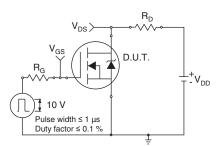


Fig. 10a - Switching Time Test Circuit

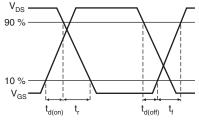


Fig. 10b - Switching Time Waveforms

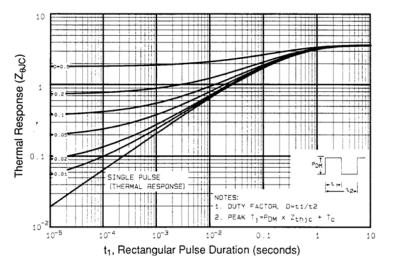


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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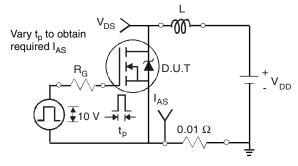


Fig. 12a - Unclamped Inductive Test Circuit

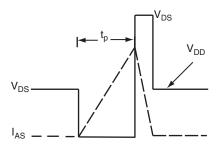


Fig. 12b - Unclamped Inductive Waveforms

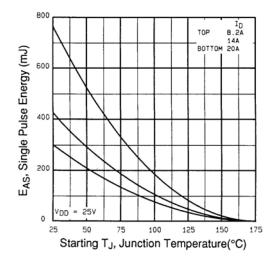


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

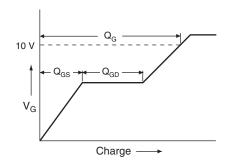


Fig. 13a - Basic Gate Charge Waveform

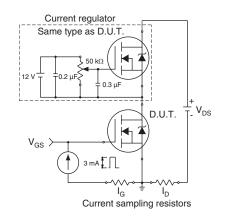
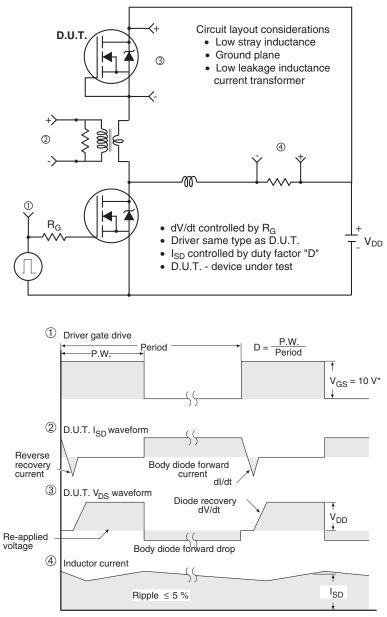


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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